

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,803	LEE ET AL.
Examiner	Art Unit
Linh V. Nguyen	2819

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SEARCHED						
Class	Subclass	Date	Examiner			
330	9,69, 254,282 284,294	6/27/2006	LN			
341	143,172	6/27/2006	LN			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
PGPUB-Text searched - see printout		2/27/2006	LN		

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
East searched - see printout	2/27/2006	LN
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